

P-Channel 60-V (D-S) MOSFET

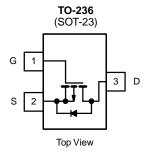
PRODUCT SUMMA	RODUCT SUMMARY				
V _{DS} (V)	- 60)			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = - 10 V	0.04			
Q _g (Max.) (nC)	12				
Q _{gs} (nC)	3.8				
Q _{gd} (nC)	5.1				
Configuration	Sing	le			

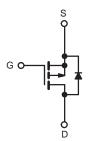
FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz



- Sink to Lead Creepage Distance = 4.8 mm
- P-Channel
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, ur	nless otherw	vise noted		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V _{DS}	- 60	V
Gate-Source Voltage			V_{GS}	± 20	V
Continuous Drain Current	V at - 10 V	$T_C = 25 ^{\circ}C$	I _D	- 5.2	
Continuous Diam Current	V _{GS} at - 10 V	$T_C = 100 ^{\circ}C$	ıD	- 3.8	Α
Pulsed Drain Current ^a			I_{DM}	- 21	
Linear Derating Factor				0.18	W/°C
Single Pulse Avalanche Energy ^b			E _{AS}	120	mJ
Repetitive Avalanche Currenta			I _{AR}	- 5.2	Α
Repetitive Avalanche Energy ^a			E_{AR}	2.7	mJ
Maximum Power Dissipation	T _C =	25 °C	P_{D}	27	W
Peak Diode Recovery dV/dtc			dV/dt	- 4.5	V/ns
Operating Junction and Storage Temperature Range			T_J,T_stg	- 55 to + 175	Ĵ
Soldering Recommendations (Peak Temperature)	for 1	10 s	•	300 ^d	
Mounting Torque	6-32 or N	6-32 or M3 screw		10	lbf ⋅ in
I Woulding Forque	1.1	N · m			

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V_{DD} = 25 V, starting T_J = 25 °C, L = 5.0 mH, R_G = 25 Ω , I_{AS} = 5.3 A (see fig. 12). c. I_{SD} < 6.7 A, dI/dt < 90 A/µs, V_{DD} \leq V_{DS} , V_{DS} = 175 °C.

- d. 1.6 mm from case.



THERMAL RESISTANCE RAT	TINGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	5.5	C/VV

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		- 60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = - 1 mA	-	- 0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	V _{GS} , I _D = - 250 μA	- 1.0	-	- 2.5	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
Zana Oata Valta va Brain Oamant	I _{DSS}	V _{DS} =	V _{DS} = - 60 V, V _{GS} = 0 V		-	- 100	
Zero Gate Voltage Drain Current		V _{DS} = - 48	V _{GS} = 0 V, T _J = 150 °C	-	-	- 500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 3.2 A ^b	-	0.05	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	- 25 V, I _D = - 3.2 A ^b	1.6	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V _{GS} = 0 V,		-	270	-	_
Output Capacitance	C _{oss}		$V_{DS} = -25 \text{ V},$		170	-	
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	31	-	pF
Drain to Sink Capacitance	С		f = 1.0 MHz		12	-	
Total Gate Charge	Qg			i	-	12	
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	$I_D = -4.7 \text{ A}, V_{DS} = -48 \text{ V},$ see fig. 6 and 13^b	i	-	3.8	nC
Gate-Drain Charge	Q _{gd}			-	-	5.1	
Turn-On Delay Time	t _{d(on)}	V_{DD} = - 30 V, I_{D} = - 4.7 A, R_{G} = 24 Ω , R_{D} = 4.0 Ω , see fig. 10 ^b		-	11	-	ns
Rise Time	t _r			-	63	-	
Turn-Off Delay Time	t _{d(off)}			-	9.6	-	
Fall Time	t _f			-	31	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s				•		,
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 5.2	А
Pulsed Diode Forward Current ^a	I _{SM}			ı	-	- 21	A
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = - 5.2 A, V _{GS} = 0 V ^b		-	_	- 5 .5	V
Body Diode Reverse Recovery Time	t _{rr}	T 25 °C 1	- 47 A dl/dt - 100 A/uch	ı	80	160	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = -4.7 \text{ A}, dI/dt = 100 \text{ A/}\mu\text{s}^b$			0.096	0.19	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	on is don	ninated by	/ L _S and I	_D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

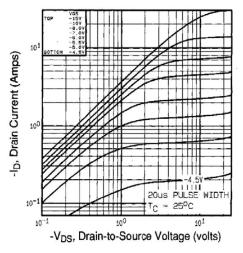


Fig. 1 - Typical Output Characteristics, T_C= 25 °C

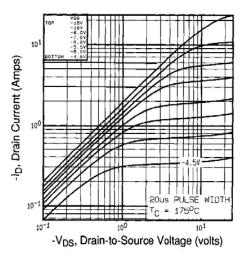


Fig. 2 - Typical Output Characteristics, T_C= 175 °C

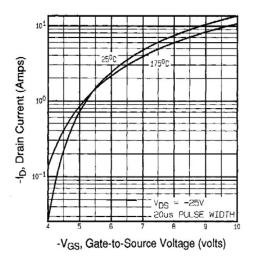


Fig. 3 - Typical Transfer Characteristics

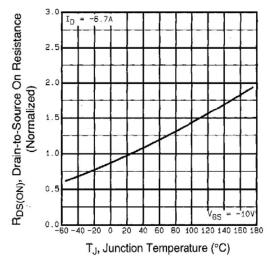


Fig. 4 - Normalized On-Resistance vs. Temperature



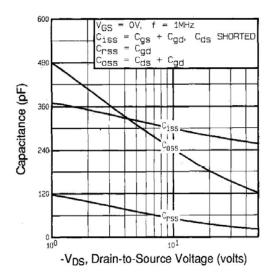


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

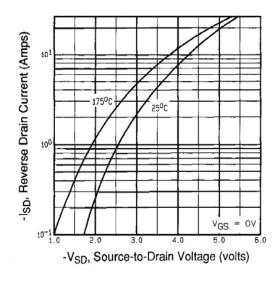


Fig. 7 - Typical Source-Drain Diode Forward Voltage

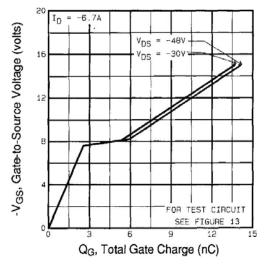


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

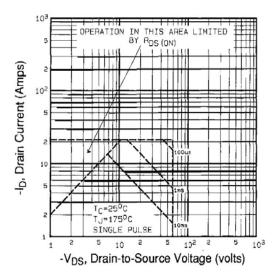


Fig. 8 - Maximum Safe Operating Area



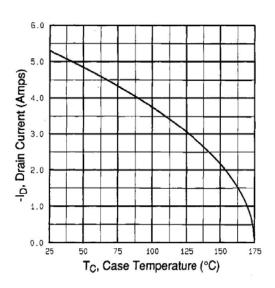


Fig. 9 - Maximum Drain Current vs. Case Temperature

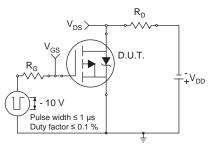


Fig. 10a - Switching Time Test Circuit

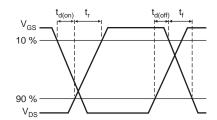


Fig. 10b - Switching Time Waveforms

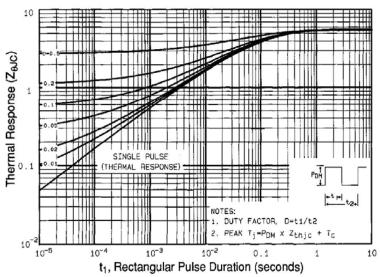


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

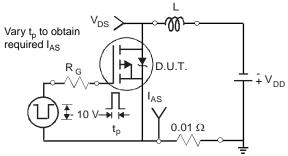


Fig. 12a - Unclamped Inductive Test Circuit

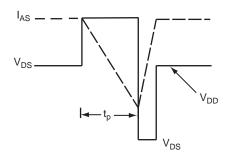


Fig. 12b - Unclamped Inductive Waveforms



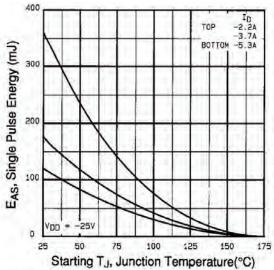


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

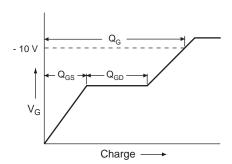


Fig. 13a - Basic Gate Charge Waveform

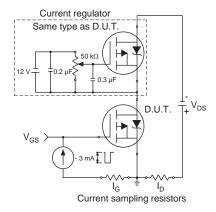
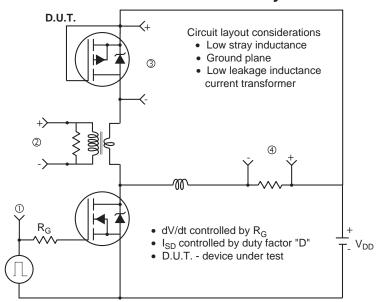


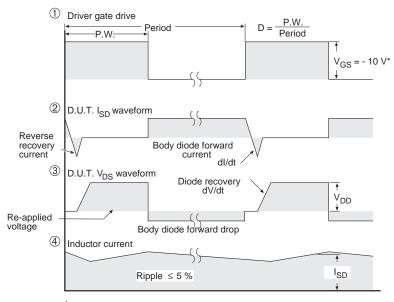
Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

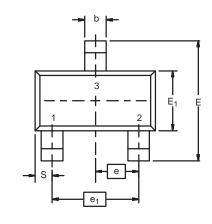


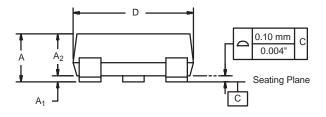
* $V_{GS} = -5 \text{ V}$ for logic level and -3 V drive devices

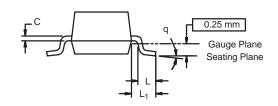
Fig. 14 - For P-Channel



SOT-23 (TO-236): 3-LEAD





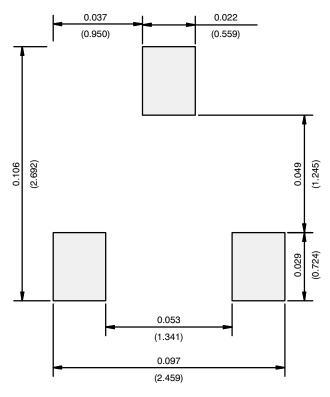


Dim	MILLIM	IETERS	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A ₁	0.01	0.10	0.0004	0.004	
A ₂	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
С	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E ₁	1.20	1.40	0.047	0.055	
е	0.95	0.95 BSC		0.0374 Ref	
e ₁	1.90	1.90 BSC		8 Ref	
L	0.40	0.60	0.016	0.024	
L ₁	0.64	0.64 Ref		Ref	
S	0.50 Ref		0.020) Ref	
q	3°	8°	3°	8°	

DWG: 5479



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)



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